

## Homework #9 - Solutions

### Problems

#### 1. Temperature Dependence of Conductivity (Kasap 5.12)

An n-type Si sample has been doped with  $10^{15}$  phosphorus atoms  $\text{cm}^{-3}$ . The donor energy level for P in Si is 0.045 eV below the conduction band edge energy.

- Calculate the room temperature conductivity of the sample.
- Estimate the temperature above which the sample behaves as if intrinsic.
- Estimate to within 20 percent the lowest temperature above which all the donors are ionized.
- Sketch schematically the dependence of the electron concentration in the conduction band on the temperature as  $\log(n)$  versus  $1/T$ , and mark the various important regions and critical temperatures. For each region draw an energy band diagram that clearly shows from where the electrons are excited into the conduction band.
- Sketch schematically the dependence of the conductivity on the temperature as  $\log(\sigma)$  versus  $1/T$  and mark the various critical temperatures and other relevant information..

### Solution

**a.** At room temperature ( $T = 300 \text{ K}$ ),  $\mu_e = 1400 \times 10^{-4} \text{ m}^2 \text{ V}^{-1} \text{ s}^{-1}$  from Table 5.1. The conductivity temperature  $T = 300 \text{ K}$  is

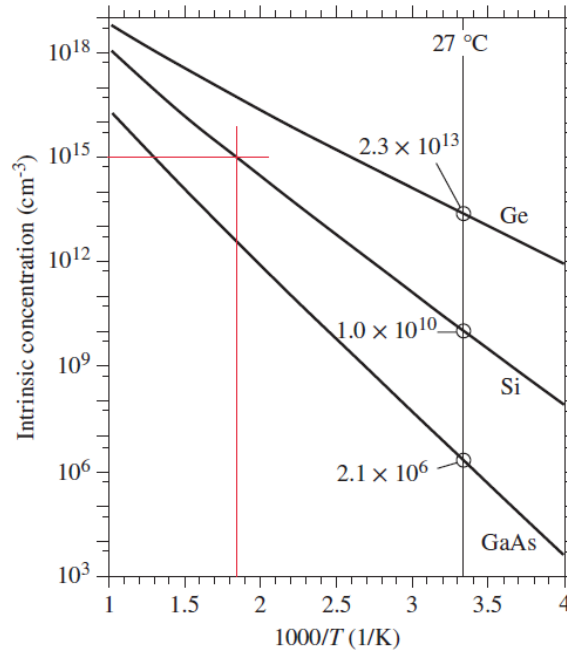
$$\sigma = eN_d\mu_e$$

$$\therefore \sigma = (1.602 \times 10^{-19} \text{ C})(1 \times 10^{21} \text{ m}^{-3})(1400 \times 10^{-4} \text{ m}^2 \text{ V}^{-1} \text{ s}^{-1}) = \mathbf{22.4 \Omega^{-1} \text{ m}^{-1}}$$

**b.** At  $T = T_i$ , the intrinsic concentration  $n_i = N_d = 1 \times 10^{15} \text{ cm}^{-3}$ . From Figure 5.16, as shown in Figure 5Q12-1, the graph of  $n_i(T)$  versus  $1/T$ ,

$$1000 / T_i = 1.85 \text{ K}^{-1}$$

$$\therefore T_i = 1000 / (1.85 \text{ K}^{-1}) = \mathbf{540 \text{ K or } 267 \text{ }^\circ\text{C}}$$



**Figure 5Q12-1** Figure 5.16, the temperature dependence of the intrinsic concentration. At  $n_i = 10^{15} \text{ cm}^{-3}$ ,  $1000/T_i = 1.85$ .

c. The ionization region ends at  $T = T_s$  when all donors have been ionized, *i.e.* when  $n = N_d$ . From Example 5.8, at  $T = T_s$ :

$$n = N_d = \left( \frac{1}{2} N_c N_d \right)^{\frac{1}{2}} \exp\left( \frac{-\Delta E}{2kT_s} \right)$$

$$\therefore T_s = \frac{-\Delta E}{2k \ln\left( \frac{N_d}{\sqrt{\frac{1}{2} N_c N_d}} \right)} = \frac{-\Delta E}{2k \ln\left( \sqrt{\frac{2N_d}{N_c}} \right)}$$

$$\therefore T_s = \frac{\Delta E}{k \ln\left( \frac{N_c}{2N_d} \right)}$$

Take  $N_c = 2.8 \times 10^{19} \text{ cm}^{-3}$  at 300 K from Table 5.1, and the difference between the donor energy level and the conduction band energy is  $\Delta E = 0.045 \text{ eV}$ . Therefore our first approximation to  $T_s$  is:

$$T_s = \frac{\Delta E}{k \ln\left( \frac{N_c}{2N_d} \right)} = \frac{(0.045 \text{ eV})(1.602 \times 10^{-19} \text{ J/eV})}{(1.381 \times 10^{-23} \text{ J/K}) \ln\left( \frac{(2.8 \times 10^{19} \text{ cm}^{-3})}{2(10^{15} \text{ cm}^{-3})} \right)} = 54.68 \text{ K}$$

Find the new  $N_c$  at this temperature,  $N_c'$ :

$$N'_c = N_c \left( \frac{T'_s}{300} \right)^{\frac{3}{2}} = (2.8 \times 10^{19} \text{ cm}^{-3}) \left( \frac{54.68 \text{ K}}{300 \text{ K}} \right)^{\frac{3}{2}} = 2.179 \times 10^{18} \text{ cm}^{-3}$$

Find a better approximation for  $T_s$  by using this new  $N'_c$ ,

$$T'_s = \frac{\Delta E}{k \ln \left( \frac{N'_c}{2N_d} \right)} = \frac{(0.045 \text{ eV})(1.602 \times 10^{-19} \text{ J/eV})}{(1.381 \times 10^{-23} \text{ J/K}) \ln \left( \frac{(2.179 \times 10^{18} \text{ cm}^{-3})}{2(10^{15} \text{ cm}^{-3})} \right)} = 74.64 \text{ K}$$

$$\therefore N''_c = N_c \left( \frac{T'_s}{300} \right)^{\frac{3}{2}} = (2.8 \times 10^{19} \text{ cm}^{-3}) \left( \frac{74.64 \text{ K}}{300 \text{ K}} \right)^{\frac{3}{2}} = 3.475 \times 10^{18} \text{ cm}^{-3}$$

A better approximation to  $T_s$  is:

$$T''_s = \frac{\Delta E}{k \ln \left( \frac{N''_c}{2N_d} \right)} = \frac{(0.045 \text{ eV})(1.602 \times 10^{-19} \text{ J/eV})}{(1.381 \times 10^{-23} \text{ J/K}) \ln \left( \frac{(3.475 \times 10^{18} \text{ cm}^{-3})}{2(10^{15} \text{ cm}^{-3})} \right)} = 69.97 \text{ K}$$

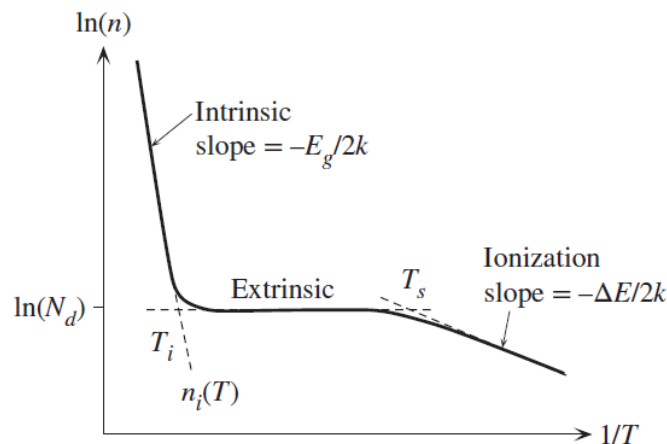
$$\therefore N'''_c = N_c \left( \frac{T''_s}{300} \right)^{\frac{3}{2}} = (2.8 \times 10^{19} \text{ cm}^{-3}) \left( \frac{69.97 \text{ K}}{300 \text{ K}} \right)^{\frac{3}{2}} = 3.154 \times 10^{18} \text{ cm}^{-3}$$

$$\therefore T'''_s = \frac{\Delta E}{k \ln \left( \frac{N'''_c}{2N_d} \right)} = \frac{(0.045 \text{ eV})(1.602 \times 10^{-19} \text{ J/eV})}{(1.381 \times 10^{-23} \text{ J/K}) \ln \left( \frac{(3.154 \times 10^{18} \text{ cm}^{-3})}{2(10^{15} \text{ cm}^{-3})} \right)} = 70.89 \text{ K}$$

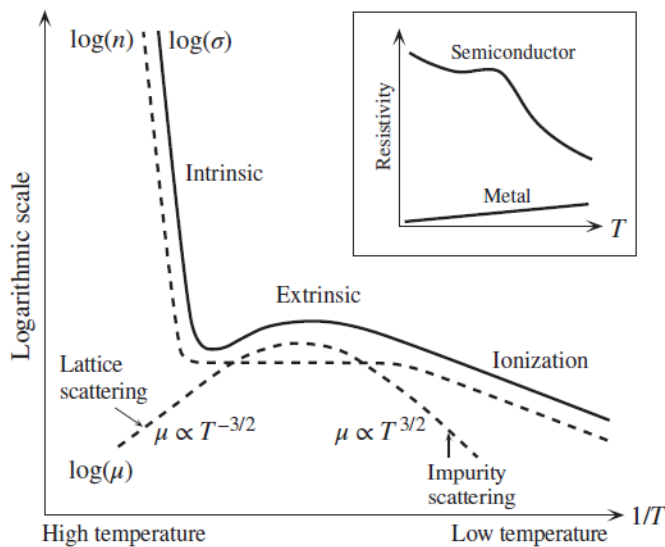
We can see that the change in  $T_s$  is very small, and for all practical purposes we can consider the calculation as converged. Therefore  $T_s = 70.9 \text{ K} = -202.1 \text{ }^\circ\text{C}$ .

**d.** and **e.**

See Figures 5.15 and 5.20



**Figure 5.15:** The temperature dependence of the electron concentration in an  $n$ -type semiconductor.



**Figure 5.20:** Schematic illustration of the temperature dependence of electrical conductivity for a doped (*n*-type) semiconductor.

## 2. Degenerate Semiconductor (Kasap 5.21)

Consider the general exponential expression for the concentration of electrons in the CB,

$$n = N_c \exp\left[-\frac{(E_c - E_F)}{kT}\right]$$

and the mass action law,  $np = n_i^2$ . What happens when the doping level is such that  $n$  approaches  $N_c$  and exceeds it? Can you still use the above expressions for  $n$  and  $p$ ?

Consider an *n*-type Si that has been heavily doped and the electron concentration in the CB is  $10^{20}$  cm<sup>-3</sup>. Where is the Fermi level? Can you use  $np = n_i^2$  to find the hole concentration? What is its resistivity? How does this compare with a typical metal? What use is such a semiconductor?

### Solution

Consider  $n = N_c \exp[-(E_c - E_F)/kT]$  (1)

and  $np = n_i^2$  (2)

These expressions have been derived using the Boltzmann tail ( $E > E_F + \text{a few } kT$ ) to the Fermi – Dirac (FD) function  $f(E)$  as in Section 5.1.4. Therefore the expressions are NOT valid when the Fermi level is within a few  $kT$  of  $E_c$ . In these cases, we need to consider the behavior of the FD function  $f(E)$  rather than its tail and the expressions for  $n$  and  $p$  are complicated.

It is helpful to put the  $10^{20} \text{ cm}^{-3}$  doping level into perspective by considering the number of atoms per unit volume (atomic concentration,  $n_{\text{at}}$ ) in the Si crystal. From Appendix C, the density is  $2.33 \text{ g cm}^{-3}$ , so that

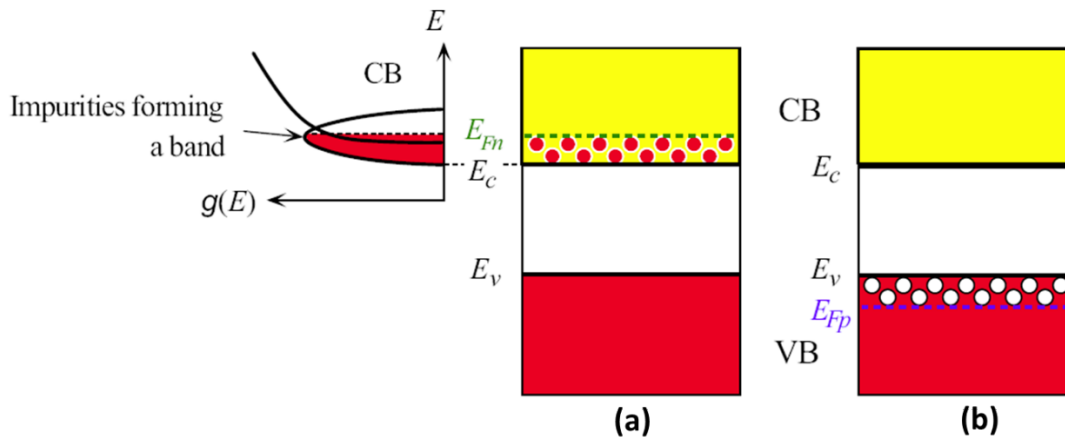
$$n_{\text{at}} = \frac{(\text{Density})N_A}{M_{\text{at}}} = \frac{(2.33 \times 10^3 \text{ kg m}^{-3})(6.022 \times 10^{23} \text{ mol}^{-1})}{(28.09 \times 10^{-3} \text{ kg mol}^{-1})}$$

*i.e.*  $n_{\text{at}} = 4.995 \times 10^{28} \text{ m}^{-3}$  or  $5.0 \times 10^{22} \text{ cm}^{-3}$

Given that the electron concentration  $n = 10^{20} \text{ cm}^{-3}$ , we see that

$$n/n_{\text{at}} = (10^{20} \text{ cm}^{-3}) / (5.0 \times 10^{22} \text{ cm}^{-3}) = 0.00200$$

which means that if all donors could be ionized we would need 1 in 500 doping or 0.2% donor doping in the semiconductor. We cannot use Equation (1) to find the position of  $E_F$ . The Fermi level will be in the conduction band. The semiconductor is degenerate. The electrical properties are more like that of a metal than that of a semiconductor. The conductivity would be very high compared to a nondegenerate semiconductor. Highly doped (degenerate) semiconductor regions in devices can replace metals by providing sufficiently high conductivity, and without needing to deposit actual metals. Degenerate semiconductors are widely used in a variety of devices, as will be apparent in Chapter 6.



**Figure 5.21** (a) Degenerate *n*-type semiconductor. Large number of donors form a band that overlaps the CB. (b) Degenerate *p*-type semiconductor.